

PCN# 20171101000 Qualify New Assembly Material set for Selected Device(s) Change Notification / Sample Request

Date:November 03, 2017To:PREMIER FARNELLPCN

Dear Customer:

This is an announcement of a change to a device that is currently offered by Texas Instruments. The details of this change are on the following pages.

We request you acknowledge receipt of this notification within **30** days of the date of this notice. Lack of acknowledgement of this notice within 30 days constitutes acceptance of the change. If you require samples or additional data to support your evaluation, please request within 30 days.

The proposed first ship date is indicated on page 3 of this notification, unless customer agreement has been reached on an earlier implementation of the change.

This notice does not change the end-of-life status of any product. Should product affected be on a previously issued product withdrawal/discontinuance notice, this notification does not extend the life of that product or change the life time buy offering/discontinuance plan.

For questions regarding this notice, contact your local Field Sales Representative or the PCN Manager (<u>PCN ww admin team@list.ti.com</u>).

Sincerely,

PCN Team SC Business Services

20171101000 Change Notification / Sample Request Attachment: 1

Products Affected:

The devices listed on this page are a subset of the complete list of affected devices. According to our records, these are the devices that you have purchased within the past twenty-four (24) months. The corresponding customer part number is also listed, if available.

DEVICE

LMX2531LQ2080E/NOPB

CUSTOMER PART NUMBER

Technical details of this Product Change follow on the next page(s).

| PCN Number: | 20171101000 | | | | PCN | Date | e: | Nov 03, 2017 | | | |
|---|-------------|---|-------------|-----------|-------------------------------|------|-----------------|------------------------------------|--|--|--|
| Title: Qualify New Assembly Material set for Selected Device(s) | | | | | | | | | | | |
| Customer Contact: | PCN Man | | | <u>r</u> | Dept: Qua | | | ity Services | | | |
| Proposed 1 st Ship Date: F | | Feb (|)3, | 2018 | Estimated Samp Availabilit | | - | Date provided at sample request | | | |
| Change Type: | | | | | | | | | | | |
| Assembly Site | | | Design | | | | Wafer Bump Site | | | | |
| Assembly Process | | | | Data She | | | | fer Bump Material | | | |
| Assembly Materials | | | | Part num | | | | afer Bump Process | | | |
| Mechanical Specification | | | | Test Site | | | | fer Fab Site | | | |
| Packing/Shipping/L | | | | Test Pro | | | | fer Fab Materials | | | |
| | | | | | | | Waf | er Fab Process | | | |
| | | | PCN Details | | | | | | | | |
| Description of Chang | e: | | | | | | | | | | |
| Texas Instruments is pleased to announce the qualification of new assembly material set to add Cu as an additional bond wire option for WQFN package devices listed in "Product affected" section below. Devices will remain in current assembly facility and piece part changes as follows: | | | | | | | | | | | |
| Material | | Current | | | Propos | | | | | | |
| Wire | | 1.2mil Au | | | 1.0mil Cu, 1.2mil Au | | | | | | |
| Reason for Change: | | | | | | | | | | | |
| Continuity of supply. 1) To align with world technology trends and use wiring with enhanced mechanical and electrical properties 2) Maximize flexibility within our Assembly/Test production sites. 3) Cu is easier to obtain and stock | | | | | | | | | | | |
| Anticipated impact on Fit, Form, Function, Quality or Reliability (positive / negative): | | | | | | | | | | | |
| None. | | | | | | | | | | | |
| Anticipated impact on Material Declaration | | | | | | | | | | | |
| No Impact to the Material Declaratio | on | Material Declarations or Product Content reports are driven from production data and will be available following the production release. Upon production release the revised reports can be obtained from the <u>TI Eco-Info website</u> . There is no impact to the material meeting current regulatory compliance requirements with this PCN change. | | | | | | | | | |
| Changes to product identification resulting from this PCN: | | | | | | | | | | | |
| None. | | | | | | | | | | | |
| Product Affected: | | | | | | | | | | | |

| LMX2531LQ1500E/NOPB | LMX2531LQX1742/NOPB | LMX2531SQE1650E/S7002603 |
|-------------------------|----------------------|--------------------------|
| LMX2531LQ1570E/NOPB | LMX2531LQX1778E/NOPB | LMX2531SQE1700E/NOPB |
| LMX2531LQ1650E/NOPB | LMX2531LQX1910E/NOPB | LMX2531SQE1742/NOPB |
| LMX2531LQ1650E/S7002162 | LMX2531LQX2080E/NOPB | LMX2531SQE1778E/NOPB |
| LMX2531LQ1700E/NOPB | LMX2531LQX2265E/NOPB | LMX2531SQE1910E/NOPB |
| LMX2531LQ1742/NOPB | LMX2531LQX2570E/NOPB | LMX2531SQE2080E/NOPB |
| LMX2531LQ1778E/NOPB | LMX2531SQ1650E/NOPB | LMX2531SQE2265E/NOPB |
| LMX2531LQ1910E/NOPB | LMX2531SQ1700E/NOPB | LMX2531SQE2570E/NOPB |
| LMX2531LQ2080E/NOPB | LMX2531SQ1742/NOPB | LMX2531SQX1650E/NOPB |
| LMX2531LQ2265E/NOPB | LMX2531SQ1778E/NOPB | LMX2531SQX1700E/NOPB |
| LMX2531LQ2570E/NOPB | LMX2531SQ1910E/NOPB | LMX2531SQX1742/NOPB |
| LMX2531LQX1500E/NOPB | LMX2531SQ2080E/NOPB | LMX2531SQX1910E/NOPB |
| LMX2531LQX1570E/NOPB | LMX2531SQ2265E/NOPB | LMX2531SQX2570E/NOPB |
| LMX2531LQX1650E/NOPB | LMX2531SQ2570E/NOPB | |
| LMX2531LQX1700E/NOPB | LMX2531SQE1650E/NOPB | |

| Qualification Data | | | | | | | | | |
|---|------|-------------------------------|--------------|--------------------|----------------|---------|---------|--|--|
| This qualification has been specifically developed for the validation of this change. The qualification data validates that the proposed change meets the applicable released technical specifications. | | | | | | | | | |
| Qualification Device: LMK04808BISQ/NOPB (MSL 3-260c) | | | | | | | | | |
| Package Construction Details | | | | | | | | | |
| Assembly Site: | TIE | М | Mold Compou | 1old Compound: | | 8095387 | | | |
| # Pins-Designator, Family: | 64-I | NKD, WQFN | Mount Compou | ount Compound: | | | 8001111 | | |
| Leadframe (Finish, Base): | Mat | te Sn, Cu | Bond Wi | re: | 1 Mil Dia., Cu | | | | |
| Qualification: 🗌 Plan 🛛 Test Results | | | | | | | | | |
| Reliability Test | | Conditions | | Sample Size / Fail | | | | | |
| | | | | Lot 1 | | Lot 2 | Lot 3 | | |
| Electrical Characterization | | Datasheet | | | ass | | | | |
| **High Temp. Storage Bake | | 150C (500, 1000 Hrs) | | | 7/0 | 77/0 | | | |
| **Autoclave 121C | | 121C, 2 ATM (96 hrs) | | | 8/0 | 78/0 | 78/0 | | |
| **T/C -65C/150C | | -65C/+150C (500 Cyc) | | | 7/0 | 77/0 | 77/0 | | |
| Visual / Mechanical | | (per mfg. Site specification) | | | ass | Pass | Pass | | |
| Ball Bond Shear | | 76 balls, 3 units min | | | ass | Pass | Pass | | |
| Bond Pull | | 76 Wire, 3 unit | Pass | | Pass | Pass | | | |
| X-ray | | (top side only) | Pass | | Pass | Pass | | | |
| Notes: **Tests received preconditioning sequence: MSL3-260C | | | | | | | | | |

For questions regarding this notice, e-mails can be sent to the regional contacts shown below or your local Field Sales Representative.

| Location | E-Mail |
|--------------|--------------------------------|
| USA | PCNAmericasContact@list.ti.com |
| Europe | PCNEuropeContact@list.ti.com |
| Asia Pacific | PCNAsiaContact@list.ti.com |
| Japan | PCNJapanContact@list.ti.com |